Modulating Low-Power Threshold Optical Bistability by Electrically Reconfigurable Free-Electron Kerr Nonlinearity

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We propose a microscopic mechanism to electrically reconfigure the Kerr nonlinearity by modulating the concentration of free electrons in heavily doped semiconductors under a static bias. Our theory incorporates electrostatic and hydrodynamic frameworks to describe the electronic dynamics, demonstrating electrically tunable linear and nonlinear modulations. The power threshold of achieving optical bistability shows unprecedented tunability over two orders of magnitude, reaching values as low as 10 μ W through surface charge control. These findings offer new insights into understanding and actively controlling Kerr nonlinearities, paving the way for efficient refractive index engineering as well as the development of advanced linear and nonlinear electro-optical modulators.

Refractive index engineering, which governs phase accumulation and light propagation, is central to a broad range of applications in both traditional optics and metaoptics $[1, 2]$ $[1, 2]$. In this context, the optical Kerr effect $[3]$ a third-order nonlinear phenomenon through which light modulates a material's refractive index based on the applied intensity—has been a promising candidate. However, conventional Kerr nonlinearities, which arise from either intrinsic bulk nonlinear susceptibilities or thermal effects, are typically limited, respectively, in strength or speed (e.g., kHz to MHz [\[4\]](#page-5-5)), and thus generally unable to support high-contrast, ultrafast modulation.

An effective way to overcome these challenges is by leveraging light confinement in nanoplasmonic structures. Resulting from collective free-electron (FE) oscillations, plasmons can significantly amplify the local fields and hence enhance nonlinearities in extremely confined volumes. Beyond the conventional nonlinear responses arising from the anharmonicity of bound electrons, the dynamics of FEs can generate strong and ultrafast optical nonlinearities, known as FE nonlinearities [\[5–](#page-5-6)[7\]](#page-5-7). Heavily doped semiconductors are particularly compelling in this context due to their ability to support exceptionally large and highly tunable optical nonlinearities [\[8,](#page-5-8) [9\]](#page-5-9). Compared to other degenerate electron systems, such as gold [\[5,](#page-5-6) [6\]](#page-5-10) and indium tin oxide [\[7,](#page-5-7) [10\]](#page-5-11), heavily doped semiconductors typically feature a lower equilibrium electron density n_0 (10¹⁸ to 10¹⁹ cm⁻³), thus typically working in the mid-infrared to THz [\[11\]](#page-5-12). Owing to the n_0^{-2} dependence of the nonlinear FE polarizability [\[12,](#page-5-13) [13\]](#page-5-14), their lower n_0 allows significant FE nonlinearities that can readily exceed the dielectric response from third-order nonlinear susceptibility $\chi^{(3)}$ [\[14\]](#page-5-15). Furthermore, since FE nonlinearities act as boundary effects [\[5,](#page-5-6) [6\]](#page-5-10), actively mod-

ulating the surface carrier density via field effects enables reconfigurable control [\[15\]](#page-5-16). Finally, unlike thermal effects that are inherently slow [\[4\]](#page-5-5), FE nonlinearities from the electric polarizability of FE can be ultrafast.

From the theoretical point of view, FE nonlinearities can be effectively described using a microscopic, electronic-level hydrodynamic theory (HT) [\[5–](#page-5-6)[7,](#page-5-7) [13,](#page-5-14) [14\]](#page-5-15). The HT is a semiclassical first-principle-level framework that can be derived from the single-particle Schrödinger equation in the limit of many electrons, by properly choosing the energy functionals as quantum corrections [\[16,](#page-6-0) [17\]](#page-6-1). Leveraging the HT, in a preliminary work [\[13\]](#page-5-14), we discovered a strong FE Kerr-type nonlinearity that enables low-threshold bistability which allows two stable outputs at the same input intensity of 1 mW. Despite its exceptional strength, the real-time tunability of FE Kerr nonlinearity remains unproven, mainly due to the absence of theoretical models for describing electrically reconfigurable effects.

In this Letter, we present a microscopic picture of the electrically tunable FE Kerr effect by implementing an electrostatics-HT coupled formalism that captures the nonlinear electron dynamics under an optical drive and field-effect gate. As a demonstration, we harness longitudinal bulk plasmons (LBPs) [\[18\]](#page-6-2) in a heavily n-doped InGaAs slab to support FE Kerr nonlinearity [\[13\]](#page-5-14). As a nonlocal resonance above the plasma frequency, the LBP in heavily doped semiconductors enables operation from the telecom band to the mid-infrared. In the system we propose here, LBPs are coupled to gold nanopatch antennas that function both as plasmonic cavities and electrodes for applying bias. Notably, the LBP resonance exhibits a high sensitivity of tunability on bias, effectively functioning as a linear modulator. From a nonlinear perspective, we prove that second-order FE nonlinearities contribute to the third-order Kerr effect via a cascaded mechanism. This conventionally negligible cascaded effect might be even stronger than the direct third-order process. By incorporating the electrostatic equation, we introduce an additional degree of freedom—the static bias voltage—to manipulate FE Kerr nonlinearities. Moreover, by electrically modulating the equilibrium density n_0 and its gradient ∇n_0 , we demonstrate the ability to tune the power threshold across a 2-order-of-magnitude range, from the level of several milliwatts down to 10 μ W, considering a focused beam to the diffraction limit. It can modulate both the contrast between on- and off-states and the width (read margin) of the hysteresis. These findings offer a microscopic understanding of Kerr nonlinearity at the nanoscale, and lay a groundwork for efficient, actively tunable linear and nonlinear devices with operating bands extending from the mid-infrared to the 1550 nm telecom band.

Understanding the motion of FEs is the key to decoding the optical responses of heavily doped semiconductors. Following the HT as in Refs. [\[12,](#page-5-13) [13,](#page-5-14) [15\]](#page-5-16), we can model microscopic FEs driven by electric E and magnetic H fields as a fluid. The equation of motion of these FEs can be described with two macroscopic quantitieselectron density $n(\mathbf{r}, t)$ and velocity $\mathbf{v}(\mathbf{r}, t)$:

$$
m_e \left(\frac{\partial}{\partial t} + \mathbf{v} \cdot \nabla + \gamma \right) \mathbf{v} = -e(\mathbf{E} + \mathbf{v} \times \mu_0 \mathbf{H}) - \nabla \frac{\delta G[n]}{\delta n}.
$$
\n(1)

 m_e , e , μ_0 are the effective mass, electron charge, and vacuum permeability respectively. The equation contains convection $(\mathbf{v}\cdot\nabla\mathbf{v})$, dissipation (phenomenological damping rate γ), Coulomb and Lorentz forces, and a quantum pressure term where an appropriate internal energy functional $G[n]$ can be selected to resolve the complex interaction in the electronic ensemble. The total electron density $n = n_0(\mathbf{r}) + \sum_j n_j(t, \mathbf{r})$ is comprised of the equilibrium electron density $n_0(\mathbf{r})$ and perturbed densities (e.g., $n_i(j\omega, \mathbf{r}), j \in \mathbb{Z}$ is the order of the harmonic). Here we consider the energy functional within the Thomas-Fermi (TF) approximation, i.e., $G[n] \simeq T_{\text{TF}}[n]$. This term is essential for accurately describing nonlocal effects in plasmonics and electron dynamics [\[18\]](#page-6-2). Additionally, more complex treatments can account for the electron spill-out effects [\[17,](#page-6-1) [19\]](#page-6-3), giving rise to a slight shift of the plasmon resonance and a spatially variant n_0 . For simplicity, we neglect the spill-out that allows the wavefunction of electrons to spread beyond the material's physical boundary; however, the gradient of n_0 can be captured as follows.

In metal-oxide-semiconductor (MOS) structures, the electron distribution is modulated by the work function difference between the metal gate and the semiconductor, and the bias voltage u on the gate. De Luca et al. demonstrated that such a distribution can indeed have a significant impact on harmonic generation [\[15\]](#page-5-16). In this

regard, we consider the electrostatic equation (Eq. [2\)](#page-1-0) that is suitable for computing the semiconductors' spatially redistributed electron $n_0(\mathbf{r})$ and hole $p_0(\mathbf{r})$ densities near the interface in the presence of a band bending φ :

$$
\nabla^2 \varphi = -e(p_0(\mathbf{r}) - n_0(\mathbf{r}) + N_D^+ - N_A^-)/\varepsilon_0 \varepsilon_r.
$$
 (2)

On the left-hand side of Eq. [\(2\)](#page-1-0) there is the Laplacian of the band bending φ , whereas the right-hand side accounts for the total charge density, including hole $p_0(\mathbf{r})$ and electron $n_0(\mathbf{r})$ densities, and ionized donor N_D^+ and acceptor N_A^+ concentrations. $\varepsilon_0 \varepsilon_r$ denotes the permittivity of the semiconductor. To solve this, we use COMSOL Multiphysics as a finite element solver for its convenience in multi-physical coupling and weak forms customization (see Supplementary Material [\[20\]](#page-6-4) for further details).

To achieve a combination of high nonlinearity and tunability, we modified the nanopatch hybrid structure [\[13\]](#page-5-14) to align with the well-established MOS configuration [\[21\]](#page-6-5). As shown in Fig. [1,](#page-1-1) periodic gold stripes are designed to sit on a 2 nm $HfO₂$ [\[22\]](#page-6-6) layer, functioning both as nanocavities [\[23\]](#page-6-7) and as gates to apply a bias for the active control. Beneath the oxide lies a thin layer of heavily doped InGaAs (14 nm thick, $N_D^+ = 6 \times 10^{18} \text{ cm}^{-3}$, $N_A^- = 0, \ \gamma = 8.9 \text{ ps}^{-1}, \ m_e = 0.041m_0, \ \varepsilon_{\text{inf}} = 12) \ [14],$ $N_A^- = 0, \ \gamma = 8.9 \text{ ps}^{-1}, \ m_e = 0.041m_0, \ \varepsilon_{\text{inf}} = 12) \ [14],$ $N_A^- = 0, \ \gamma = 8.9 \text{ ps}^{-1}, \ m_e = 0.041m_0, \ \varepsilon_{\text{inf}} = 12) \ [14],$ which supports LBPs [\[13\]](#page-5-14). Applying an external static field will tailor the FE $n_0(\mathbf{r})$ near the surface, as demonstrated by solving Eq. [\(2\)](#page-1-0) under different gate bias voltages u (see Methods [\[20\]](#page-6-4)).

FIG. 1. (a) The schematic of the nanopatch-InGaAs MOS configuration with external bias modulation. The height h and thickness q of the antenna is 50 nm and 14 nm, respectively. The length L and periodicity P_x can vary. (b) equilibrium FE n_0 accumulation ($u = 1$ V) and depletion ($u = 0.6$ V) tuned by the gate bias voltage u. Lower panels of (b): the induced charge (first-order perturbed) n_1 of the hybrid third-order LBPs in the InGaAs. (c) Bias-dependent spatial distribution of n_0 along the dashed line in (b).

The upper panels in Fig. [1b](#page-1-1) show the spatial distribution (i.e., depletion and accumulation) of n_0 with two different biases, 0.6 V and 1.0 V, respectively. As $u \approx 0.8$ V (Fig. [1c](#page-1-1)), n_0 almost remains constant in space because the applied voltage balances the difference in work functions and aligns the Fermi levels (flat band condition). Therefore, we set 0.8 V as a reference gate bias u_0 . In turn, in Fig. [1b](#page-1-1), when $u = 1$ V (the relative bias $\Delta u = u - u_0 = 0.2$ V), n_0 near the gate increases significantly to $12.2 \times 10^{18} \text{ cm}^{-3}$ (accumulation condition), which is twice the value found away from the gate. In contrast, when $u = 0.6$ V ($\Delta u = -0.2$ V), a depletion condition is observed, with a value of n_0 on the surface that is 4.3 times smaller than in the bulk. The spatial n_0 under different bias in Fig. [1c](#page-1-1) proves that the charge modulation is typically a surface effect with an effective depth of the order of 10 nm. However, since the semiconductor thickness (14 nm) here is comparable with this depth, the surface charge modulation can have an exceptional influence on the electrical and optical performances. Such small semiconductor thicknesses combined with the small effective mass of FE typically lead to 2D confinement of free electrons and to discrete electron energy states in a quantum well [\[21,](#page-6-5) [24\]](#page-6-8). However, it has been shown [\[25\]](#page-6-9) that for the very high electron density levels considered in this work, which are not typically used in quantum wells, the electromagnetic excitation spectrum is defined by the FE density parameter alone, and the thin semiconductor layer becomes a 3D plasmonic conductor with a continuum of energy levels, and not by the energy distance between discrete states as in a quantum well.

From the nonlinearity side, we choose the LBP because it is a charge density wave in the bulk (fields shown as Fig. [1b](#page-1-1)) that overlaps with the physical dimension of InGaAs which guarantees enough active interaction volume and strong nonlinearity [\[13\]](#page-5-14). As shown in the lower panels of Fig. [1b](#page-1-1), the induced charge n_1 of LBP can well overlap with the depletion layer configured by the bias. The optical response can be described by Eq. [\(3\)](#page-2-0), the constitutive relation at the *j*-harmonic [\[15\]](#page-5-16) by adjusting the Eq. [\(1\)](#page-1-2) with the relation $\dot{\mathbf{P}} = \mathbf{J} = -nev$:

$$
\frac{\partial^2 \mathbf{P}_j}{\partial t^2} + \gamma \frac{\partial \mathbf{P}_j}{\partial t} = \frac{n_0(\mathbf{r})e^2}{m_e} \mathbf{E}_j + \beta^2 \nabla (\nabla \cdot \mathbf{P}_j)
$$

$$
-\frac{1}{3} \frac{\beta^2}{n_0} (\nabla \cdot \mathbf{P}_j) \nabla n_0 + \mathbf{S}_{\omega_j}^{\text{NL}},
$$
 (3)

where the first-order TF-quantum pressure term has been written as $\frac{en_0}{m_e} \nabla (\frac{\delta T_{\rm TF}}{\delta n})_1 = \beta^2 \nabla (\nabla \cdot \mathbf{P}_j) - \frac{1}{3} \frac{\beta^2}{n_0}$ $\frac{\beta^2}{n_0}(\nabla\!\cdot\!{\bf P}_j)\nabla n_0.$ The factor $\beta(\mathbf{r})$ is related to the sound speed in the Fermidegenerate plasma v_F [\[26\]](#page-6-10), $\beta(\mathbf{r})^2 = \frac{3}{5}v_F^2 = 2\frac{c_{TF}}{m_e}n_0(\mathbf{r})^{2/3}$, $c_{\rm TF}$ = $\frac{\hbar}{m}$ $\frac{\hbar}{m_e^2} \frac{3}{10} (3\pi^2)^{2/3}$. This equation only explicitly contains the linear terms, while the nonlinear contributions are encapsulated in $S_{\omega_j}^{NL}$ and will be discussed below. By coupling Eqs. [\(2\)](#page-1-0), [\(3\)](#page-2-0) (assuming $S_{\omega_j}^{NL}$ = 0) with Maxwell's equation in the frequency domain, $\nabla \times \nabla \times \mathbf{E}_j - \varepsilon_r \frac{\omega_j^2}{c^2} \mathbf{E}_j - \mu_0 \omega_j^2 \mathbf{P}_j = 0$, we can now an-

alyze the electrical modulation of linear optical response $(j = 1)$. Nonlinear responses $(S_{\omega_j}^{\text{NL}} \neq 0)$ will be studied in the time domain separately later.

Figure [2](#page-2-1) illustrates the linear, electrical modulation of the plasmonic resonances by the bias u within a system with $L = 184$ nm, $P_x = 280$ nm. As $\Delta u = 0$, the reflectance presents two distinct resonances at $\lambda = 2.2$ and 2.4 μ m (Fig. [2a](#page-2-1)). As discussed in Ref. [\[13\]](#page-5-14), the narrow resonance is a LBP resonance in the InGaAs layer. This LBP has been experimentally observed in various degenerate electron systems, e.g., alkali metals [\[27\]](#page-6-11), transparent conducting oxides [\[28\]](#page-6-12), and heavily doped semiconductors [\[29\]](#page-6-13). Enhanced by the nanopatch fundamental mode ($\simeq 2.4 \,\mu$ m), this prominent hybrid LBP is an ideal platform for generating bistability with low power consumption.

Applying a relative bias Δu on the antenna from -0.25 to 0.20 V can induce a significant blueshift of the LBP (Fig. [2b](#page-2-1))—with a sensitivity of $\frac{\Delta\lambda}{\Delta u} = 0.89 \frac{\mu m}{V}$ at the $\Delta u = 0$. This tunability is due to the condition of charge accumulation and depletion. For $\Delta u > 0$, n_0 tends to accumulate near the interface which leads to an effective blueshift in the plasma wavelength $\lambda_p(\mathbf{r}) =$ $2\pi c\sqrt{m_e\varepsilon_0\varepsilon_{\rm inf}/(n_0(\mathbf{r})e^2)}$. Conversely, for $\Delta u < 0$, the resonance redshifts accordingly due to the depletion. During the shift, the LBP maintains a strong interaction with light, resulting in an absorption of over 70%. These results reveal the sensitivity and effectiveness of linear electrical modulation, where the finding of these electrically tunable plasmons in semiconductors paves to road to wide applications in optical switches, modulators, and sensors in the infrared.

We now investigate the nonlinear modulation of the optical bistability via the FE-driven Kerr effect. To do so, we have to solve the nonlinear problem self-consistently in the time domain to allow the field to be self-modulated by its own intensity. Here, as indicated by $\mathbf{S}_{\omega_1}^{(3)}$ and $\mathbf{S}_{\omega_1}^{(2)}$, we for the first time elaborate on the role of third- and second-order (i.e., via cascaded effects) FE nonlinearities respectively in Kerr effects. Fields and nonlinear sources are expanded by harmonics for an clearer comparison of different contributions:

FIG. 2. Linear spectral modulation as a function of the applied bias (b) with one specific case (a), $\Delta u = 0$. The sketches in (a) represent the resonances of LBP due to the nonlocality in the InGaAs and LSP in the nanopatch cavity.

$$
\mathbf{S}_{\omega_2}^{(2)} = \frac{e}{m_e} \mathbf{E}_1 \nabla \cdot \mathbf{P}_1 - \frac{e\mu_0}{m_e} \dot{\mathbf{P}}_1 \times \mathbf{H}_1 + \frac{1}{en_0} (\dot{\mathbf{P}}_1 \nabla \cdot \dot{\mathbf{P}}_1 + \dot{\mathbf{P}}_1 \cdot \nabla \dot{\mathbf{P}}_1) - \frac{1}{en_0^2} \dot{\mathbf{P}}_1 (\dot{\mathbf{P}}_1 \cdot \nabla n_0)
$$
\n
$$
+ \frac{1}{9} \frac{\beta^2}{en_0^2} [3n_0 \nabla (\nabla \cdot \mathbf{P}_1)^2 - (\nabla \cdot \mathbf{P}_1)^2 \nabla n_0],
$$
\n(4a)

$$
\mathbf{S}_{\omega_1}^{(2)} = \frac{e}{m_e} (\mathbf{E}_1^* \nabla \cdot \mathbf{P}_2 + \mathbf{E}_2 \nabla \cdot \mathbf{P}_1^*) - \frac{e\mu_0}{m_e} (\dot{\mathbf{P}}_1^* \times \mathbf{H}_2 + \dot{\mathbf{P}}_2 \times \mathbf{H}_1^*) + \frac{1}{en_0} (\dot{\mathbf{P}}_1^* \nabla \cdot \dot{\mathbf{P}}_2 + \dot{\mathbf{P}}_2 \nabla \cdot \dot{\mathbf{P}}_1^* + \dot{\mathbf{P}}_1^* \cdot \nabla \dot{\mathbf{P}}_2 + \dot{\mathbf{P}}_2 \cdot \nabla \dot{\mathbf{P}}_1^*)
$$

$$
- \frac{1}{en_0^2} \left[\dot{\mathbf{P}}_1^* (\dot{\mathbf{P}}_2 \cdot \nabla n_0) + \dot{\mathbf{P}}_2 (\dot{\mathbf{P}}_1^* \cdot \nabla n_0) \right] + \frac{2}{9} \frac{\beta^2}{en_0^2} \left[3n_0 \nabla \left[(\nabla \cdot \mathbf{P}_2)(\nabla \cdot \mathbf{P}_1^*) \right] - (\nabla \cdot \mathbf{P}_2)(\nabla \cdot \mathbf{P}_1^*) \nabla n_0 \right],
$$
(4b)

$$
\mathbf{S}_{\omega_{1}}^{(3)} = -\frac{1}{e^{2}n_{0}^{2}} [\nabla \cdot \mathbf{P}_{1}^{*} \dot{\mathbf{P}}_{1} \nabla \cdot \dot{\mathbf{P}}_{1} + \nabla \cdot \mathbf{P}_{1} \dot{\mathbf{P}}_{1}^{*} \nabla \cdot \dot{\mathbf{P}}_{1} + \nabla \cdot \mathbf{P}_{1} \dot{\mathbf{P}}_{1} \nabla \cdot \dot{\mathbf{P}}_{1}^{*} + \nabla \cdot \mathbf{P}_{1} \dot{\mathbf{P}}_{1}^{*} \cdot \nabla \dot{\mathbf{P}}_{1} + \nabla \cdot \mathbf{P}_{1} \dot{\mathbf{P}}_{1}^{*} \cdot \nabla \dot{\mathbf{P}}_{1} + \nabla \cdot \mathbf{P}_{1} \dot{\mathbf{P}}_{1} \cdot \nabla \dot{\mathbf{P}}_{1}^{*} + 2 \dot{\mathbf{P}}_{1}^{*} \dot{\mathbf{P}}_{1} \nabla \nabla \cdot \mathbf{P}_{1} + \dot{\mathbf{P}}_{1} \dot{\mathbf{P}}_{1} \nabla \nabla \cdot \mathbf{P}_{1}^{*}]
$$
\n
$$
+ \frac{2}{e^{2}n_{0}^{3}} [(\nabla \cdot \mathbf{P}_{1}^{*}) \dot{\mathbf{P}}_{1} (\dot{\mathbf{P}}_{1} \cdot \nabla n_{0}) + (\nabla \cdot \mathbf{P}_{1}) \dot{\mathbf{P}}_{1}^{*} (\dot{\mathbf{P}}_{1} \cdot \nabla n_{0}) + (\nabla \cdot \mathbf{P}_{1}) \dot{\mathbf{P}}_{1} (\dot{\mathbf{P}}_{1}^{*} \cdot \nabla n_{0})] - \frac{4}{27} \frac{\beta^{2}}{e^{2}n_{0}^{3}} \Big[\frac{3}{4} n_{0} \nabla [\nabla \cdot \mathbf{P}_{1}^{*} (\nabla \cdot \mathbf{P}_{1})^{2}] - \nabla \cdot \mathbf{P}_{1}^{*} (\nabla \cdot \mathbf{P}_{1})^{2} \nabla n_{0}], \tag{4c}
$$

where $\mathbf{S}_{\omega_2}^{\text{NL}} = \mathbf{S}_{\omega_2}^{(2)}$ generates the second harmonic $(\omega_2 =$ $2\omega_1$) waves and the Kerr nonlinear sources can be broken down according to the orders of the processes $\mathbf{S}_{\omega_1}^{\textrm{NL}}=$ ${\bf S}^{(2)}_{\omega_1}+{\bf S}^{(3)}_{\omega_1}$. The "." and "*" on the variables denote the time derivative and complex conjugate, respectively. Note that Eqs. [\(4a\)](#page-3-0)-[\(4c\)](#page-3-1) contain contributions from the gradient of the equilibrium density, i.e., ∇n_0 , which may have a significant influence on the nonlinear sources near the interface due to the abrupt change of n_0 (Fig. [1c](#page-1-1)). Beyond this, nonlinear sources contain terms proportional to n_0^{-1} and n_0^{-2} . It suggests an electrically reconfigurable Kerr effect controlled by bias u that a depletion of n_0 will significantly enhance the nonlinearity, and conversely, an accumulation may reduce it. As a first note, here we have derived a full picture of hydrodynamic Kerr nonlinearity (Eqs. $(4b),(4c)$ $(4b),(4c)$ $(4b),(4c)$) under bias $(u$ may contribute via $n_0(\mathbf{r})$ and are ready to implement them once coupled with the time-domain wave equation for the vector potential $\mathbf{A}^{(j)}(\mathbf{r},t)$ at j-th harmonic:

$$
\nabla \times \nabla \times \mathbf{A}_j + \frac{\varepsilon_r}{c^2} \frac{\partial^2 \mathbf{A}_j}{\partial t^2} + \mu_0 \frac{\partial}{\partial t} (\mathbf{P}_j + \mathbf{P}_d^{\mathrm{NL}}) = 0. \quad (5)
$$

Here, the electromagnetic fields are connected to \mathbf{A}_j by $\mathbf{E}_j = -\partial \mathbf{A}_j/\partial t$ and $\mu_0 \mathbf{H}_j = \nabla \times \mathbf{A}_j$. The Kerr nonlinearity from the dielectric can be considered with a polarization $\mathbf{P}_{d}^{NL} = 3\varepsilon_0 \chi^{(3)} |\mathbf{E}|^2 \mathbf{E}$ with the susceptibility $\chi^{(3)} = 1.6 \times 10^{-18} \text{ m}^2/\text{V}^2 \text{ [3]}.$ $\chi^{(3)} = 1.6 \times 10^{-18} \text{ m}^2/\text{V}^2 \text{ [3]}.$ $\chi^{(3)} = 1.6 \times 10^{-18} \text{ m}^2/\text{V}^2 \text{ [3]}.$

After solving the system of equations given by Eqs. [\(2\)](#page-1-0)-[\(5\)](#page-3-3) based on the nanopatch of Fig. [2a](#page-2-1), here we compare the contributions of Kerr nonlinearity from the direct and cascaded process. As shown in Fig. [3a](#page-4-0), the input wavelength is red-detuned compared with the LBP resonance, i.e., $\lambda_0 = 2.23 \ \mu \text{m}$, the LBP mode $\lambda = 2.2 \ \mu \text{m}$,

detuning $\Delta \lambda = \lambda_0 - \lambda = 30$ nm. The Kerr effect through a direct third-order process $(\mathbf{S}_{\omega_1}^{(3)})$ will form bistability with a intensity threshold of 5 mW/ μ m². In contrast, the cascaded process, which includes difference-frequency contributions arising from the second-order nonlinearity $(\mathbf{S}_{\omega_1}^{(2)})$, results in a significantly lower threshold of approximately 1.5 mW/ μ m² for blue-detuned excitation $(\Delta \lambda = -50$ nm), accompanied by a wider hysteresis (Fig[.3b](#page-4-0), cyan curve). Two hysteresis loops are observed in the reflectance (Fig. [3b](#page-4-0)) due to the existence of two resonances, i.e., LBP and LSP on the lower-energy side of the input λ_0 . Interestingly, these results suggest that the direct process is a Kerr effect with positive effective susceptibility that will redshift the resonance $(n_{2\text{Kerr}} > 0,$ $n_{2\text{Kerr}}$ is nonlinear refractive index) while the cascaded process can be a "negative" that reshapes the resonance to the blue side $(n_{2\text{Kerr}} < 0)$.

Since the direct and cascaded Kerr effects exert opposite dephasing in this specific structure, combining both effects, $S_{\omega_1}^{(2)} + S_{\omega_1}^{(3)}$, for direct comparison can be useful. We observe that the hysteresis (purple curve in Fig[.3b](#page-4-0)) shifts towards a higher intensity threshold, while its overall shape remains unchanged. These three scenarios, i.e., direct (red), cascaded (cyan), and their combination (purple), reveal for the first time that the cascaded contributions, a second-order process, can even dominate in the FE Kerr effect. This offers a new channel to engineer the FE Kerr nonlinearity such as by designing dualresonant antennas that can enhance both harmonics. In addition, the FE nonlinearity due to both cascaded and direct processes can be dominant over traditional $\chi^{(3)}$, since the latter has been proven to be much weaker than the direct FE Kerr effect [\[13\]](#page-5-14).

FIG. 3. Comparison of the hysteresis resulted from different nonlinear sources: dielectric $\chi^{(3)}$ plus hydrodynamic terms (a) with the direct process only (red), (b) with the cascaded process only (cyan), and their combination (purple). Colorful lines in insets mark the laser wavelengths λ_0 which are detuned from the resonance with $\Delta\lambda$.

Finally, we investigate how the bias field tunes the optical bistability. In Fig. [4a](#page-4-1) we present a statistics study for the optical bistabilities under different biases Δu , and detunings $\Delta\lambda$. Specific examples of Δu (Figs. [4b](#page-4-1)-e) and $\Delta\lambda$ (Figs. [4f](#page-4-1)-h) dependencies are discussed. We investigate three InGaAs thicknesses: 8 nm, 11 nm (Fig. S3 [\[20\]](#page-6-4)), and 14 nm. To fairly compare the strength of Kerr nonlinearity under different biases, in every scenario of Fig. [4,](#page-4-1) we keep the detunings of the LBP and LSP the same as that shown in Fig. [2a](#page-2-1). See details in Fig. S2 [\[20\]](#page-6-4). There are three crucial charactetristics of a bistable hysteresis: modulation depth (contrast), hysteresis width, and the power threshold. The contrast influences the fidelity, the width guarantees the writing and reading margins of optical memory, and the threshold determines the power consumption. As shown in the legend, we use the size of the scatters to indicate the hysteresis's width, $w = 2 \frac{I_{\text{th1}} - I_{\text{th2}}}{I_{\text{th1}} + I_{\text{th2}}}.$ I_{th1} and I_{th2} , defined at the halfmaximum of the hysteresis, represent the thresholds for switching the states off and on. Then, the contrast is defined as the difference in reflectance between the maximum and minimum of the two stable states, which is indicated by the color of the scatters. The green and red shades mark the regions where the perturbed electron density n_1 is smaller than 20% and 50% of the minima of $n_0(\mathbf{r})$ under different biases, respectively. This indicates the limit set by the perturbative approach in the Taylor expansion $(n_1/n_0 \ll 1)$, which is the assumption [\[12\]](#page-5-13) while deriving the FE hydrodynamic nonlinearities (Eq. [\(4b\)](#page-3-2)-[\(4a\)](#page-3-0)). With these quantitative metrics, we can now assess our idea of tuning nonlinearity by a bias.

In Fig. [4a](#page-4-1), the squares (the InGaAs layer thickness $g = 14$ nm) are generally distributed above the spheres $(q = 8 \text{ nm})$, indicating that they require higher intensities to generate bistable states. Diamonds $(q = 11 \text{ nm})$ are apparently in between them, shown in Fig. S3 [\[20\]](#page-6-4). While a larger thickness can diminish the field confinement in the nanopatch, it can also increase the interaction length, maintaining a decent modulation contrast (indicated by the colors of the markers). As we reduce the

FIG. 4. Low-power threshold optical bistabilities electrically modulated by static bias. (a) Statistics of the power threshold for achieving bistability as a function of bias voltage and InGaAs slab thickness $(g = 8, 14 \text{ nm})$. See statistical data for $g = 11$ nm in [\[20\]](#page-6-4). The sizes (colors) of the markers represent the width (contrast) of the hysteresis. Left panels (b-e) show hysteresis loops of four specific examples with different Δu marked in (a). The right panels (f-h) show a hysteresismerging mechanism of the system with the same bias but different detunings. (i) shows the hysteresis with the lowest threshold collected in the statistics.

InGaAs thickness from 14 nm to 8 nm, we can observe a significant drop in the threshold I_{th1} , accompanied by an increase in the hysteresis width, as indicated by the generally larger sizes of the circles than the squares. The contrast of $q = 8$ nm systems can still be pronounced due to the compensation of the field enhancement over the loss of interaction dimension. More importantly, as shown by the gray guide-to-eye lines, the threshold for systems with smaller gap thickness $(g = 8 \text{ nm})$ is more sensitive to the bias voltage compared to those with $q = 14$ nm. This high sensitivity can be attributed to the larger ratio of the charge modulation depth to the total material thickness.

Whereas q is an unreconfigurable parameter, we hereby study the dependence of the power threshold and modulation contrast on electrical tuning u . As illustrated by the colors and vertical-axis positions of the markers in Fig[.4a](#page-4-1), the charge accumulation $(\Delta u > 0)$ increases the contrast as well as the threshold, respectively. Conversely, charge depletion ($\Delta u < 0$) has the opposite effect, reducing them. The power threshold drops because the depletion (lower n_0) will strengthen the $\mathbf{S}_{\omega_1}^{\text{NL}}$ due to the factors of n_0^{-1} , n_0^{-2} and the ∇n_0 near the surface. Meanwhile, the depletion decreases the number of electrons that may participate in the absorption, which decreases the contrast as a trade-off. Charge accumulation has the opposite effect.

On the other hand, as shown by the red and green shades in Fig. [4a](#page-4-1), both charge depletion and accumulation may decrease the limit of maximum excitation intensity. Notably, the nonlinear process will saturate once as most of the FE are excited $(n_1 \simeq n_0)$. Thus, charge depletion reduces n_0 , causing quicker saturation, while accumulation enhances the electric field, increasing polarizability (higher n_1 for the same input field) and facilitating easier saturation. Based on this, for each Δu , we increase the $\Delta\lambda$ to probe the best bistable behaviors (large contrast and width) under the strongest possible excitation within the saturation restrictions: $n_1(\mathbf{r}) \leq 0.2$ to $0.5n_0(\mathbf{r})$. As indicated by three specific cases when $\Delta u = 0.2$ V in the Figs. [4f](#page-4-1)-h, tuning $\Delta \lambda$ from 16 nm to 20 nm can gradually merge the two hysteresis loops (i.e., from the LBP and LSP, respectively) into one. This allows engineering the modulation contrast as well as the hysteresis width. With a larger detuning, $\Delta \lambda = 18$ and 20 nm, the modulation depth is greatly enhanced by 2 times compared with $\Delta\lambda = 16$ nm case, while $\Delta\lambda = 18$ nm case may have a slightly larger width than $\Delta\lambda = 20$ nm. The detuning $\Delta\lambda$ has long been recognized as a tool for modulating the hysteresis width [\[30\]](#page-6-14). It can also serve as an unprecedentedly interesting method for designing bistability via merging hysteresis loops from multiple modes. It offers the freedom to engineer both the width and contrast of the hysteresis.

Figures [4b](#page-4-1)-d exemplify a few hysteresis loops (whose labels are marked in Fig. [4a](#page-4-1)), with different charge depletion by Δu from -0.10 to -0.25 V close to the saturation limit. As n_0 is more depleted, the intensity threshold drops from 500 to 35 μ W/ μ m² with a lower modulation contrast down to 10%. The minimal power threshold achieved near the 20% saturation limit (Fig[.4i](#page-4-1)) is 17.5 μ W/ μ m², yet with a 5% contrast. In summary, the electrical tuning of the FE Kerr nonlinearity always requires a balance between power consumption (threshold) and modulation contrast. To pursue an exceptionally low power consumption, one has to achieve efficient charge depletion through a bias. On the other hand, for a stronger modulation with high fidelity, one needs charge accumulation. Notably, even with charge accumulation, the power threshold remains as low as the milliwatt level (considering a diffraction-limit beam size) which is exceptionally efficient. In addition, judiciously designing the multimode systems and engineering the bistabilities by merging two or more hysteresises via tuning $\Delta\lambda$ can be an interesting tool for memory device design.

In conclusion, we have proposed a mechanism to electrically modulate the nanoscale Kerr nonlinearity and optical bistability. By incorporating a microscopic HT with the carrier transport dynamics of semiconductors, we demonstrate that a static field can efficiently modulate both linear and nonlinear optical responses by spa-

tially varying the FE equilibrium density. Varying biases, a charge depletion will significantly decrease the power threshold of the bistability from thousands of down to tens of $\mu W/\mu m^2$. On the contrary, charge accumulation will give rise to a wide $(> 70\%)$ and high-contrast $(\sim 40\%)$ bistability with a still decent threshold of several $mW/\mu m^2$. Moreover, we unveil that the often-neglected cascaded contributions in the Kerr effect can also be dominant in this system. Our findings open a viable avenue

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for active ultrafast nonlinear devices with low power con-

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